DEP & REF

Room 307

<u>PATENT</u>

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Customer Number: 20277

#13/ Ry For

Masanobu IWASAKI, et al.

Docket No.: 50090-334

Confirmation Number:

06-01-04

Serial No.: 09/934,474

Group Art Unit: 3723

Filed: August 23, 2001

Examiner: H. Shakeri

POLISHING SOLUTION SUPPLY SYSTEM, METHOD OF SUPPLYING POLISHING SOLUTION, APPARATUS FOR AND METHOD OF POLISHING SEMICONDUCTOR SUBSTRATE AND METHOD OF MANUFACTURING SEMICONDUCTOR DEVICE

REQUEST FOR REFUND

Mail Stop Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

A refund in the amount of \$410.00 is hereby requested in the above-identified application for the following reason:

A Response to the Order Returning Undocketed Appeal to Examiner was filed on November 17, 2003. No Request for Extension of Time was required for this response. Please refer to the copy of the USPTO Pair Page attached. Please note that no other papers were filed that required Requests for Extension of Time. The fee of \$410.00 was erroneously charged on February 12, 2004 under Control No. 5.

Please immediately credit Deposit Account number 500417 in this amount.

410.00 CK

Respectfully submitted,

MCDERMOTT, WILL & EMERY

600 13th Street, N.W. Washington, DC 20005-3096 (202) 756-8000 AJS/Ird Facsimile: (202) 756-8087

Date: April 26, 2004



United States Patent and Trademark Office

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PATENT APPLICATION INFORMATION RETRIEVAL





Other Links



Se	earch results for a	pplication number	··00/024 474
Number:	09/934,474	Customer Number	
Filing or 371(c) Date:	08-23-2001	Status	Reply Brief Noted
Application Type:		Status Date:	03-17-2003
Examiner Name:		Location:	TC 3700 CENTRAL
Group Art Unit:	3723	Location Date:	CP2-10C25
Confirmation Number:	8431	Earliest Publication	
Attorney Docket Number:	50090-334	No: Earliest Publication Date:	05-30-2002
Class/ Sub- Class:	451/041	Patent Number:	
First Named Inventor:	Masanobu Iwasaki, Tokyo, (JP)	Issue Date of Patent:	
Title Of	Polishing solution suppolition, apparatus for	ply system, method of s and method of polishin of manufacturing semico	

Select Search Option

Published Documents

Search

substrate and method of manufacturing semiconductor device

Marine		File History
Number	Date	Contents December
36	04-07-2004	Contents Description Mail Miscellaneous Communication to Applicant
35	04-06-2004	Miscellaneous Communication to Applicant
34	11-17-2003	
33	11-17-2003	This sould incomme Latter
32	10-02-2003	Miscellaneous Incoming Letter
31	05-20-2003	Appeal Awaiting BPAI Docketing
30	04-22-2003	Order Returning Undocketed Appeal to the Examiner
29	03-18-2003	Appear Awaiting BPAI Docketing
28		Mail Reply Brief Noted by Examiner
27	03-17-2003	Reply Brief Noted by Examiner
	01-27-2003	Date Forwarded to Examiner
26	01-22-2003	Reply Brief Filed
25	11-22-2002	Mail Examiner's Answer
24	11-21-2002	Examiner's Answer to Answer
23	11-14-2002	Examiner's Answer to Appeal Brief Date Forwarded to Examiner

22	11-04-2002	Appeal Brief Filed
21	09-04-2002	Notice of Appeal Filed PANCH
20	09-04-2002	Request for Extension of Time - Granted
19	07-26-2002	Mail Advisory Action (PTOL - 303)
18	07-26-2002	Advisory Action (PTO 1303) 11 10: 59
17	07-25-2002	Date Forwarded to Examiner
16	07-18-2002	Amendment after Final Rejection
15	04-18-2002	Mail Final Rejection (PTOL - 326)
14	04-16-2002	Final Rejection
13	03-13-2002	Date Forwarded to Examiner
12	03-04-2002	Response after Non-Final Action
11	12-04-2001	Mail Non-Final Rejection
10	11-28-2001	Non-Final Rejection
9	08-23-2001	Request for Foreign Priority (Palante P
8	08-23-2001	Request for Foreign Priority (Priority Papers May Be included) Information Disclosure Statement (IDS) Filed
7	10-29-2001	Case Docketed to Examiner in GAU
6	10-01-2001	Application Dispatched from OIPE
5	09-28-2001	Correspondence Address Change
4	09-28-2001	Correspondence Address Change
3	09-27-2001	Correspondence Address Change
2	08-29-2001	IFW Scan & PACR Auto Security Review
1	08-23-2001	Initial Exam Team nn

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